

# N-Channel MOSFET



# **Applications:**

- Adaptor
- Charger
- .SMPS

# Features:

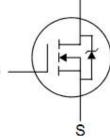
- RoHS Compliant
- . Low ON Resistance
- . Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

### **Ordering Information**

| PART NUMBER | PACKAGE | BRAND |
|-------------|---------|-------|
| FTB07N08N   | TO-263  | IPS   |

| V <sub>DSS</sub> | R <sub>DS(ON)</sub> (Typ.) | Ι <sub>D</sub> |
|------------------|----------------------------|----------------|
| 85V              | 6mΩ                        | 120A           |





D

#### Absolute Maximum Ratings

 $T_C=25^{\circ}C$  unless otherwise specified

| Symbol                        | Parameter   | FTP07N08N      | Units |
|-------------------------------|---|----------------|-------|
| V <sub>DSS</sub>              | Drain-to-Source Voltage                             | 85             | V     |
| I <sub>D</sub>                | Continuous Drain Current                            | 120            | Α     |
|                               | Continuous Drain Current $T_C = 100^{\circ}C$       | 85             | Α     |
| I <sub>DM</sub>               | Pulsed Drain Current (NOTE *1)                      | 480            | Α     |
| D                             | Power Dissipation                                   | 208            | W     |
| P <sub>D</sub>                | Derating Factor above 25°C                          | 1.8            | W/°C  |
| V <sub>GS</sub>               | Gate-to-Source Voltage                              | ±20            | V     |
| E <sub>AS</sub>               | Single Pulse Avalanche Energy(NOTE *2)              | 650.25         | mJ    |
| TL                            | Maximum Temperature for Soldering                   | 300            |       |
| $T_{\rm J}$ and $T_{\rm STG}$ | Operating Junction and Storage<br>Temperature Range | 150, -55 to150 | °C    |

#### Thermal Resistance

| Symbol           | Parameter           | Max. | Units | Test Conditions                             |
|------------------|---------------------|------|-------|---|
| Б                | Junction-to-Case    | 0.55 |       | Water cooled heatsink, $P_D$ adjusted for a |
| R <sub>θJC</sub> | Junction-to-Case    | 0.55 | °C/W  | peak junction temperature of +150℃.         |
| R <sub>0JA</sub> | Junction-to-Ambient | 65.2 |       | 1 cubic foot chamber, free air.             |



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|---|-----------------------------------|------|------|------|--------------|---|
| Symbol  | Parameter                         | Min. | Тур. | Max. | Units        | Test Conditions   |
| $BV_{DSS}$  | Drain-to-Source Breakdown Voltage | 85   |      |      | V            | V <sub>GS</sub> =0V, I <sub>D</sub> =250µA                        |
| I <sub>DSS</sub>  | Drain-to-Source Leakage Current   |      |      | 1    | - μA<br>- nA | V <sub>DS</sub> =85V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =25℃  |
|   |                                   |      |      | 100  |              | V <sub>DS</sub> =68V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =100℃ |
| I <sub>GSS</sub>  | Gate-to-Source Forward Leakage    |      |      | +100 |              | V <sub>GS</sub> =+20V   |
|   | Gate-to-Source Reverse Leakage    |      |      | -100 |              | V <sub>GS</sub> = -20V  |

#### **OFF Characteristics** $T_C=25^{\circ}C$ unless otherwise specified

#### **ON Characteristics** $T_J=25^{\circ}C$ unless otherwise specified

| Symbol              | Parameter                                     | Min. | Тур. | Max. | Units | Test Conditions                           |
|---------------------|---|------|------|------|-------|---|
| R <sub>DS(ON)</sub> | StaticDrain-to-Source On-Resistance           |      | 6.0  | 7.5  | mΩ    | V <sub>GS</sub> =10V, I <sub>D</sub> =60A |
| V <sub>GS(TH)</sub> | Gate Threshold Voltage                        | 2    |      | 4    | V     | $V_{DS}=V_{GS}$ , $I_{D}=250\mu$ A        |
| Pulse width <       | $\leqslant$ 300µs; duty cycle $\leqslant~$ 2% |      |      |      |       |   |

### Dynamic Characteristics Essentially independent of operating temperature

| Symbol           | Parameter                       | Min. | Тур.  | Max. | Units | Test Conditions                             |
|------------------|---------------------------------|------|-------|------|-------|---|
| C <sub>iss</sub> | Input Capacitance               |      | 4572  |      |       |   |
| C <sub>oss</sub> | Output Capacitance              |      | 494.4 |      | pF    | $V_{GS}$ = 0V, $V_{DS}$ = 25V<br>f =1.0MHz  |
| C <sub>rss</sub> | Reverse Transfer Capacitance    |      | 253   |      |       |   |
| Qg               | Total Gate Charge               |      | 74.4  |      | nC    | $I_D$ =60A, $V_{DD}$ =64V<br>$V_{GS}$ = 10V |
| Q <sub>gs</sub>  | Gate-to-Source Charge           |      | 21.9  |      |       |   |
| Q <sub>gd</sub>  | Gate-to-Drain ("Miller") Charge |      | 22.4  |      |       |   |

### **Resistive Switching Characteristics** Essentially independent of operating temperature

| Symbol              | Parameter           | Min. | Тур.  | Max. | Units | Test Conditions   |
|---------------------|---------------------|------|-------|------|-------|---|
| t <sub>d(ON)</sub>  | Turn-on Delay Time  |      | 35.7  |      | ns    | $V_{DD}$ =40V, I <sub>D</sub> =60A,<br>$V_{GS}$ =10V R <sub>G</sub> =6Ω |
| t <sub>rise</sub>   | Rise Time           |      | 65.6  |      |       |   |
| t <sub>d(OFF)</sub> | Turn-Off Delay Time |      | 67.2  |      |       |   |
| t <sub>fall</sub>   | Fall Time           |      | 21.87 |      |       |   |



| Symbol          | Parameter                           | Min. | Тур. | Max. | Units      | Test Conditions             |
|-----------------|-------------------------------------|------|------|------|------------|-----------------------------|
|                 | Continuous Source Current           |      |      | 120  | А          |                             |
| I <sub>S</sub>  | (Body Diode)                        |      |      |      |            | T 25°C                      |
| I <sub>SM</sub> | Maximum Pulsed Current              |      |      | 480  | A          | − T <sub>C</sub> =25℃       |
|                 | (Body Diode)                        |      |      |      |            |                             |
| V <sub>SD</sub> | Diode Forward Voltage               |      |      | 1.2  | V          | $I_{SD}$ =60A, $V_{GS}$ =0V |
| t <sub>rr</sub> | Reverse Recovery Time               |      | 72   |      | ns         | I <sub>S</sub> = 20A        |
| Q <sub>rr</sub> | Reverse Recovery Charge             |      | 126  |      | nC         | di/dt=100A/us               |
| Pulse width     | $\leq$ 300µs; duty cycle $\leq 2\%$ |      | -    | -    | . <u> </u> |                             |

#### **Source-Drain Diode Characteristics** Tc=25°C unless otherwise specified

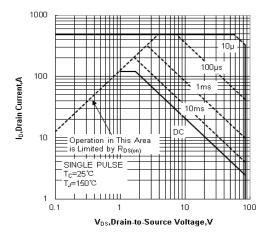
Notes:

\*1. Repetitive rating; pulse width limited by maximum junction temperature.

\*2. L=0.5mH, I<sub>D</sub>=51A, Start T<sub>J</sub>=25℃



### **Characteristics Curve:**





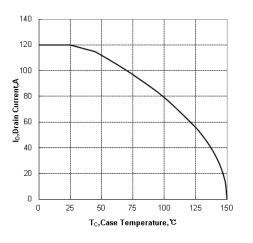


Figure 3 Maximum Continuous Drain Current vs Case Temperature

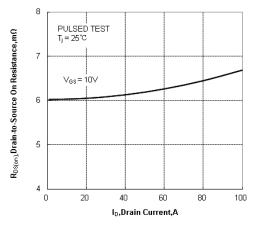


Figure 5 Drain-to-Source On Resistance vs Drain Current

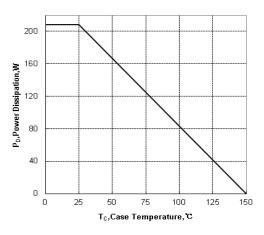


Figure 2 Maximum Power Dissipation vs Case Temperature

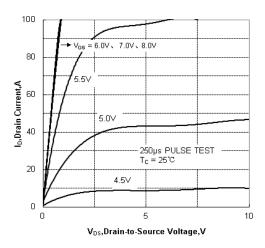


Figure 4 Typical Output Characteristics

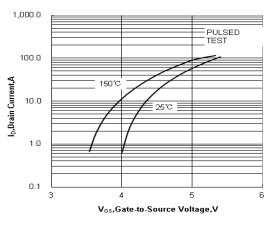
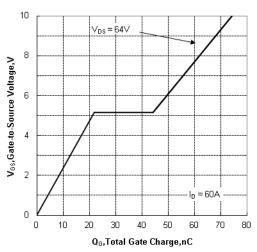


Figure 6 Typical Transfer Characteristics





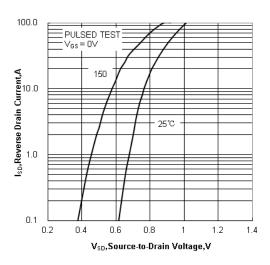


Figure 7 Typical Gate Charge vs Gate to Source Voltage

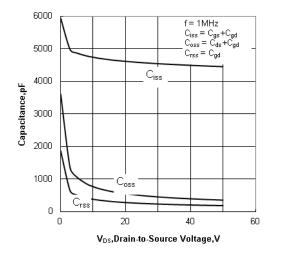


Figure 9 Typical Capacitance vs Drain to Source Voltage

Figure 8 Typical Body Diode Transfer Characteristics

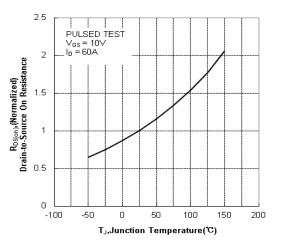
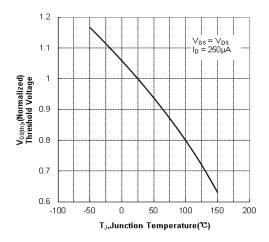


Figure10 Typical Drian to Source on Resistance vs Junction Temperature





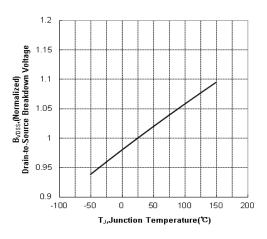
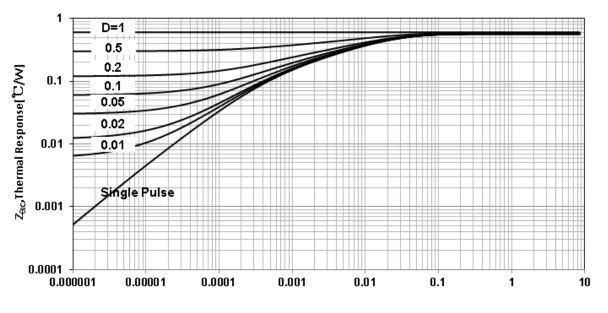


Figure11 Typical Theshold Voltage vs Junction Temperature

Figure12 Typical Breakdown Voltage vs Junction Temperature



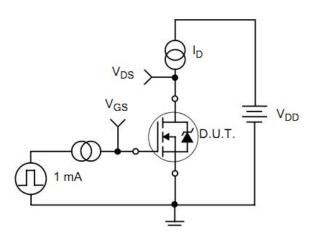
T, Rectangular Pulse Duration [sec]

Figure 13 Maximum Effective Transient Thermal Impedance, Junction-to-Case



### **Test Circuits and Waveforms**

Figure 14. Gate Charge Test Circuit



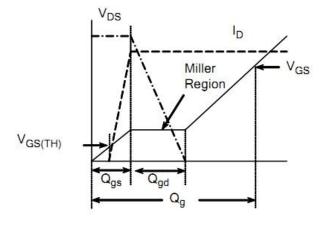
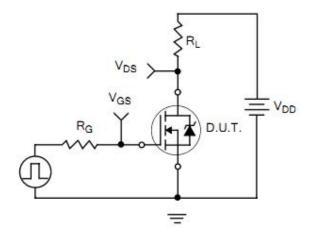
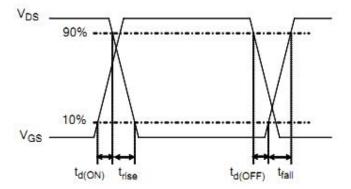


Figure 15. Gate Charge Waveforms

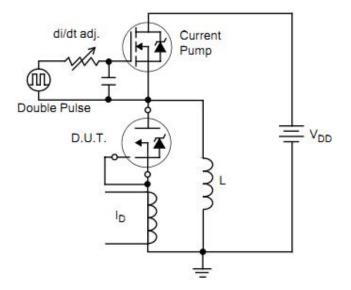
Figure 16. Resistive Switching Test Circuit

Figure 17. Resistive Switching Waveforms









#### Figure 18. Diode Reverse Recovery Test Circuit

Figure 19. Diode Reverse Recovery Waveform

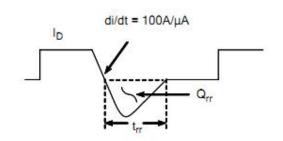
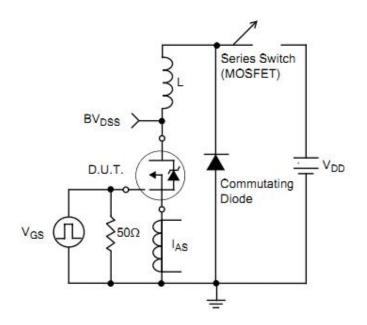
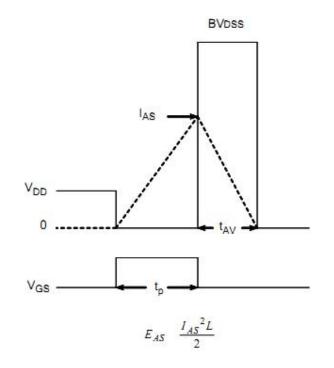


Figure 20. Unclamped Inductive Switching Test Circuit









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